

Notice of References Cited	Application/Control No. 10/717,170		Applicant(s)/Patent Under Reexamination DANZ ET AL.	
	Examiner Crystal J. Barnes		Art Unit 2121	Page 1 of 1

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*	B	US-7,050,808	05-2006	Janusz et al.	455/445
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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